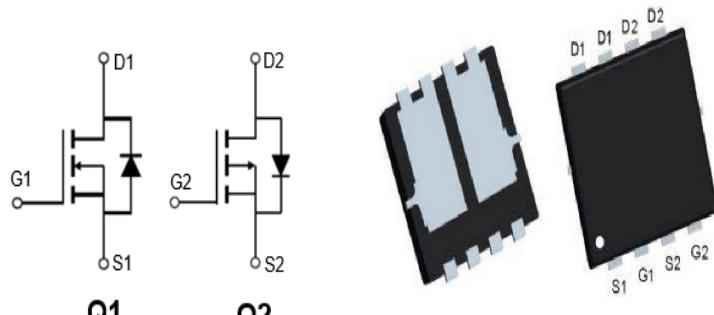


30V/-30V N and P-Channel Enhancement Mode MOSFET
Features

- Q1: $V_{DS}=30V; I_D=30A$
- Q1: $R_{DS(ON)}=10m\Omega$ (TYP.) $V_{GS}=10V, I_D=$
- Q2: $V_{DS}=-30V; I_D=-26A$
- Q2: $R_{DS(ON)}=20m\Omega$ (TYP.) $V_{GS}=-10V, I_D$
- Reliable and Rugged
- High Current Capability
- Low On-Resistance

PDFN5060

Applications

- Load Switch
- Power management in portable/desktop PCs
- DC/DC conversion

Ordering Information

Device	package	Device Marking	Package Qty.
VSP008C03MD	PDFN5060	*	5000/PCS

Absolute Maximum Ratings ($T_A=25^\circ C$,unless otherwise noted)

Parameter	Symbol	Value(Q1)	Value(Q2)	Unit
Drain-Source Voltage ($V_{GS}=0V$)	V_{DS}	30	-30	V
Gate-Source Voltage ($V_{GS}=0V$,static)	V_{GS}	± 20	± 20	V
Continuous Drain Current ($T_C=25^\circ C$)	I_D	30	-26	A
Continuous Drain Current ($T_C=100^\circ C$)		20	-18	A
Pulses Drain Current	I_{DM}	110	-100	A
Avalanche Current	I_{AS}	12	-16	A
Single Pulsed Avalanche Energy	E_{AS}	20	18	mJ
Maximum Power Dissipation ($T_C=25^\circ C$)	P_D	4	4.5	W
Maximum Power Dissipation ($T_C=100^\circ C$)		2	2.5	W
Operating,Storage Temperature Range	T_J, T_{STG}	-55~150	-55~150	°C

Q1:Electrical Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=40V, V_{GS}=0V$	-	-	1	μA
Gate -Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.1	1.5	1.9	V
Drain-Source On-stage Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=1A$	-	7.5	10	$m\Omega$
		$V_{GS}=4.5V, I_D=1A$	-	11	18	

Thermal Characteristics

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance,Junction-to-Case	R _{θJC}	14	-	°C / W
Thermal Resistance,Junction-to-Ambient	R _{θJA}	63	-	°C / W

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	V _{DS} =20V V _{GS} =0V f=1MHz	-	935	-	pF
Output capacitance	C _{oss}		-	128	-	
Reverse transfer capacitance	C _{rss}		-	105	-	
Gate Resistance	R _g	f=1MHz	-	3.9	-	Ω
Total Gate Charge	Q _g	V _{DS} =20V V _{GS} =10V I _D =6A	-	10	-	nC
Gate Source Charge	Q _{gs}		-	3.2	-	
Gate Drain Charge	Q _{gd}		-	2	-	
Turn-on delay Time	t _{d(on)}	V _{GS} =10V V _{DS} =20V R _L =3.2Ω R _G =3Ω	-	5	-	ns
Rise time	t _r		-	3	-	
Turn-off delay Time	t _{d(off)}		-	16	-	
Fall time	t _f		-	6	-	
Body Diode Forward Voltage	V _{SD}	V _{GS} =0V,I _{SD} =1A	-	0.7	1	V
Reverse Recovery Time	t _{rr}	V _{GS} =0V,I _{SD} =6A d _i /d _t =500A/μs	-	10	-	ns
Reverse Recovery Charge	Q _{rr}		-	13	-	nC

Q1:Electrical Characteristics Diagrammes

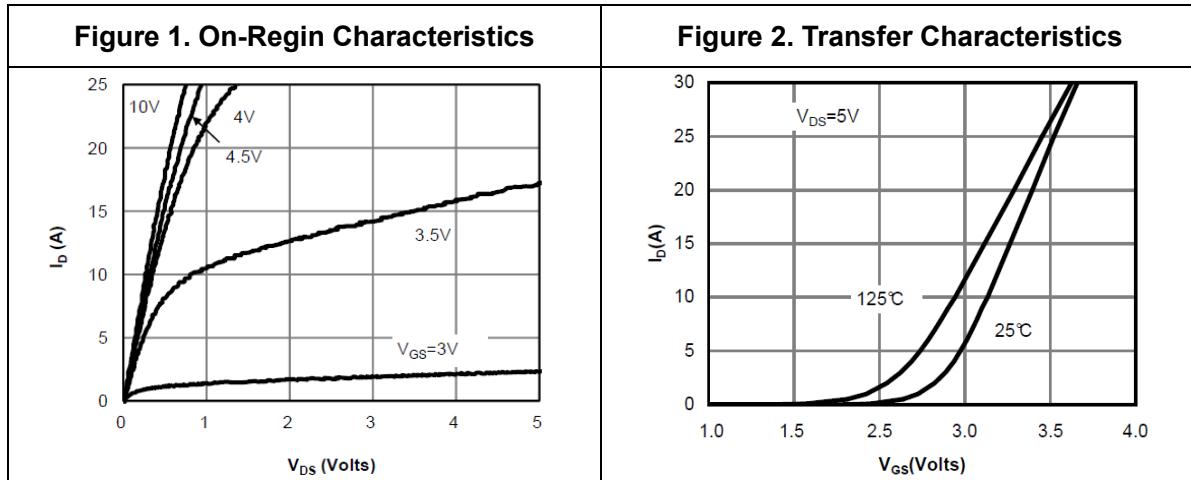


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

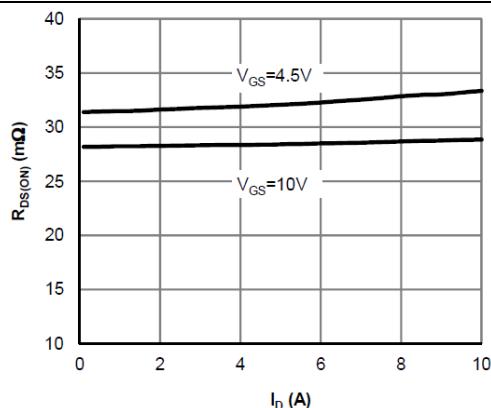


Figure 4. On-Resistance vs. Junction Temperature

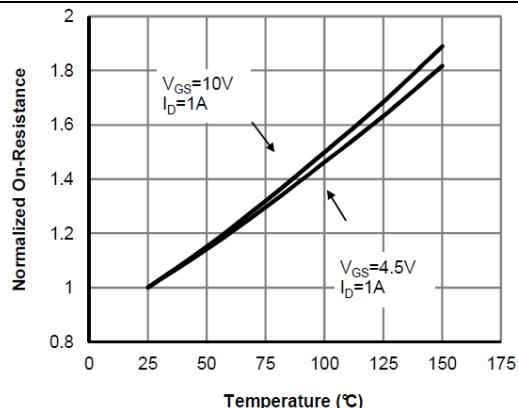


Figure 5. On-Resistance vs. Gate-Source Voltage

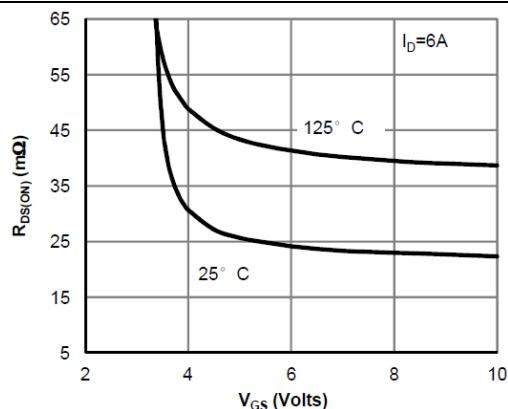


Figure 6. Body-Diode Characteristics

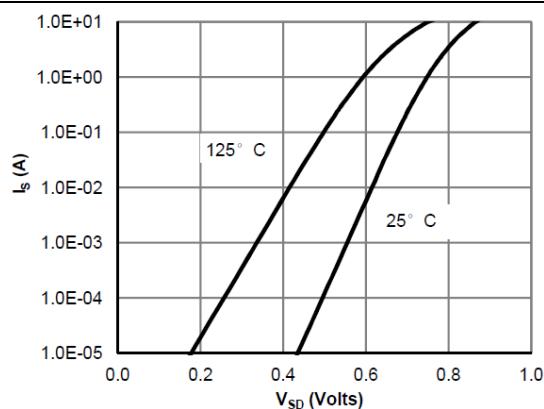


Figure 7. Gate-Charge Characteristics

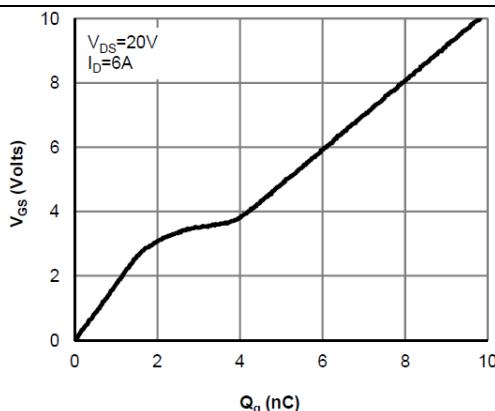
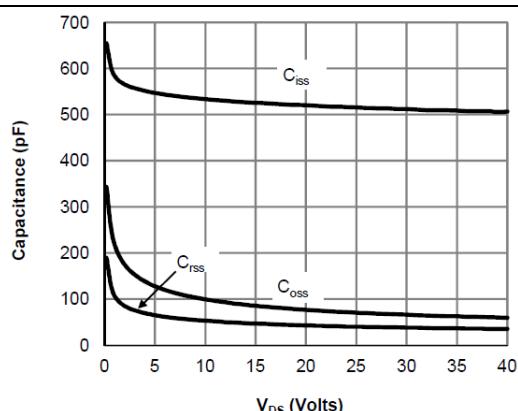
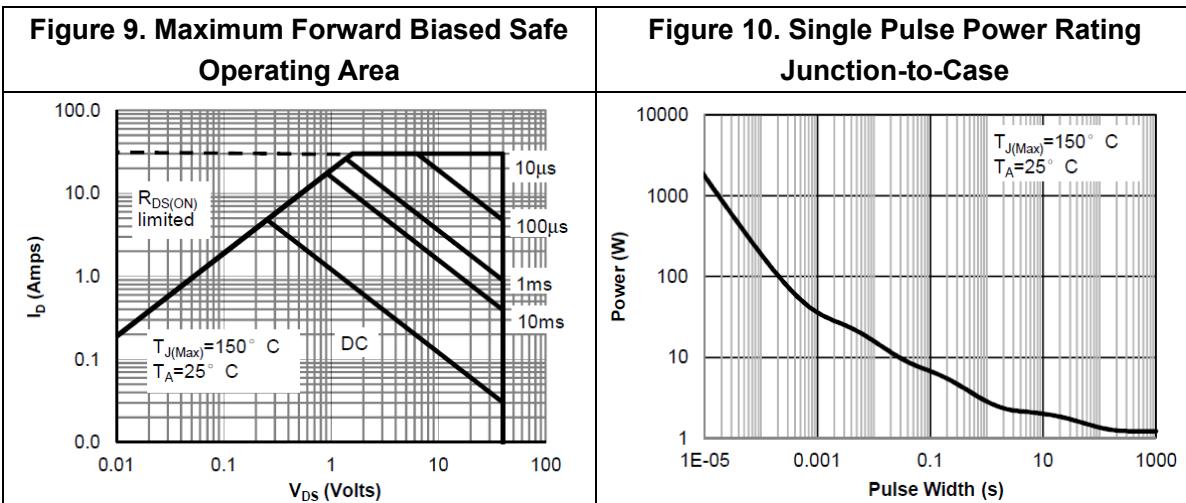


Figure 8. Capacitance Characteristics





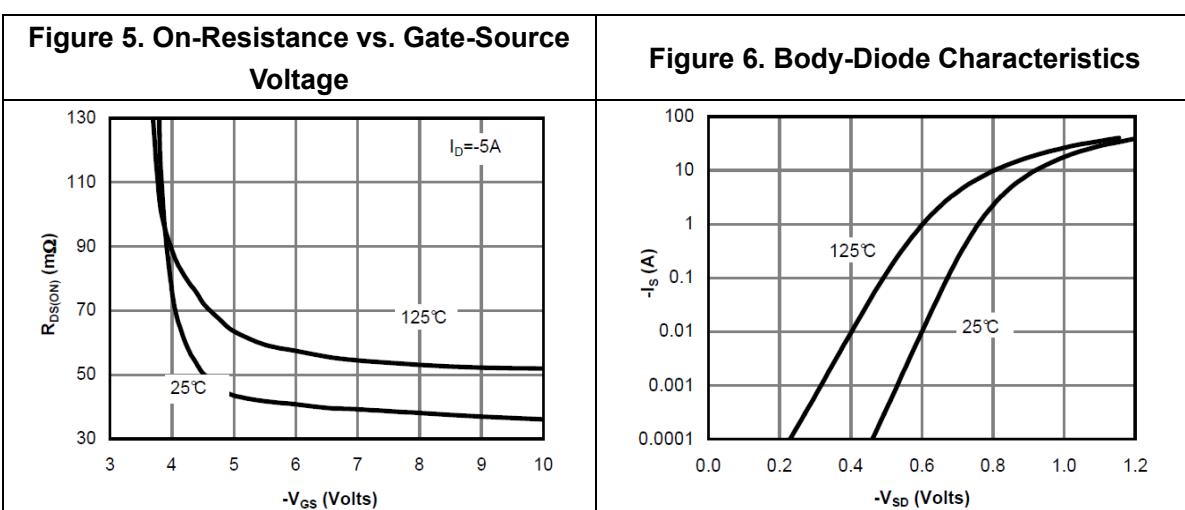
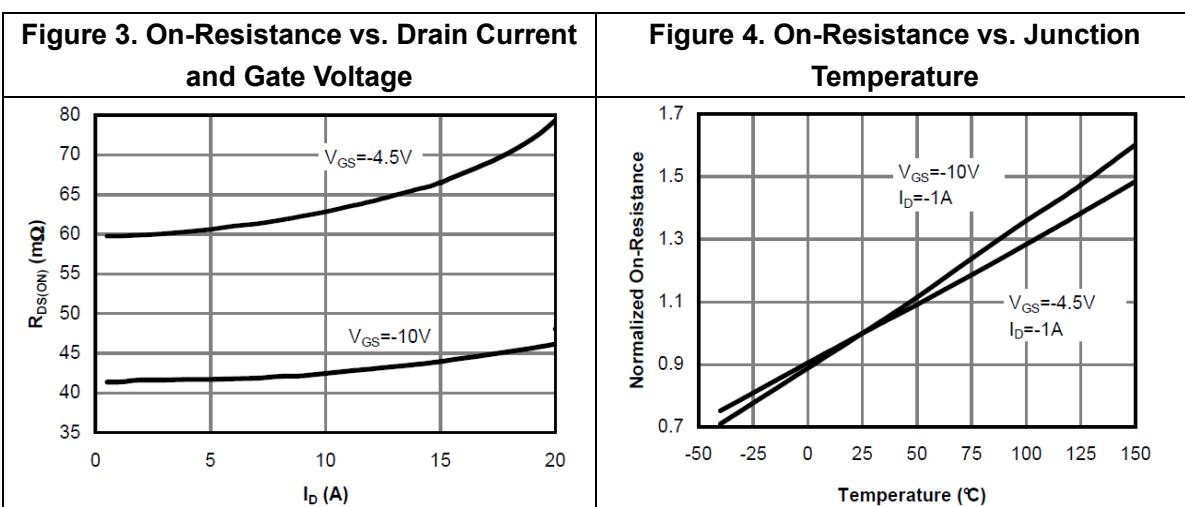
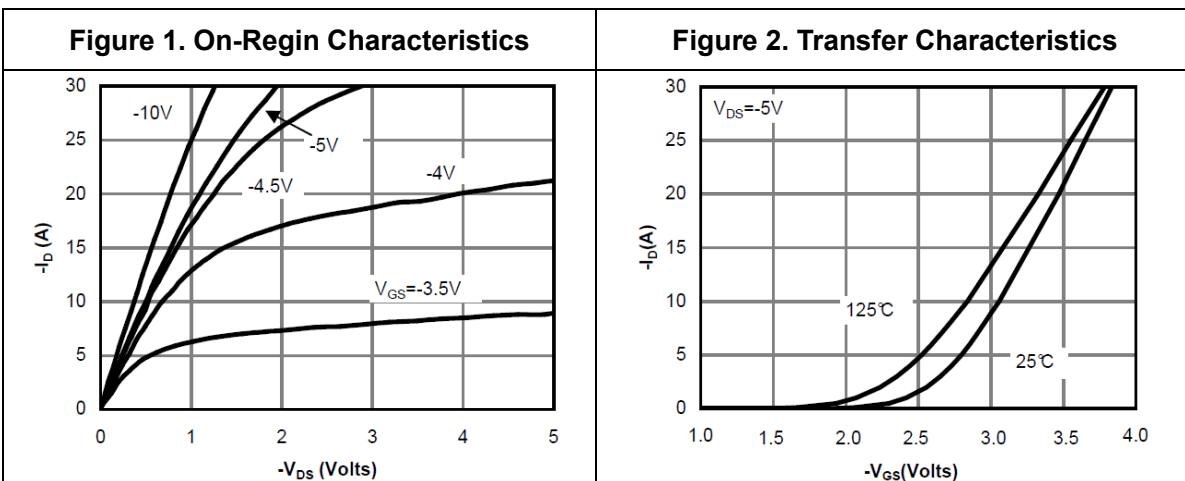
Q2: Electrical Characteristics

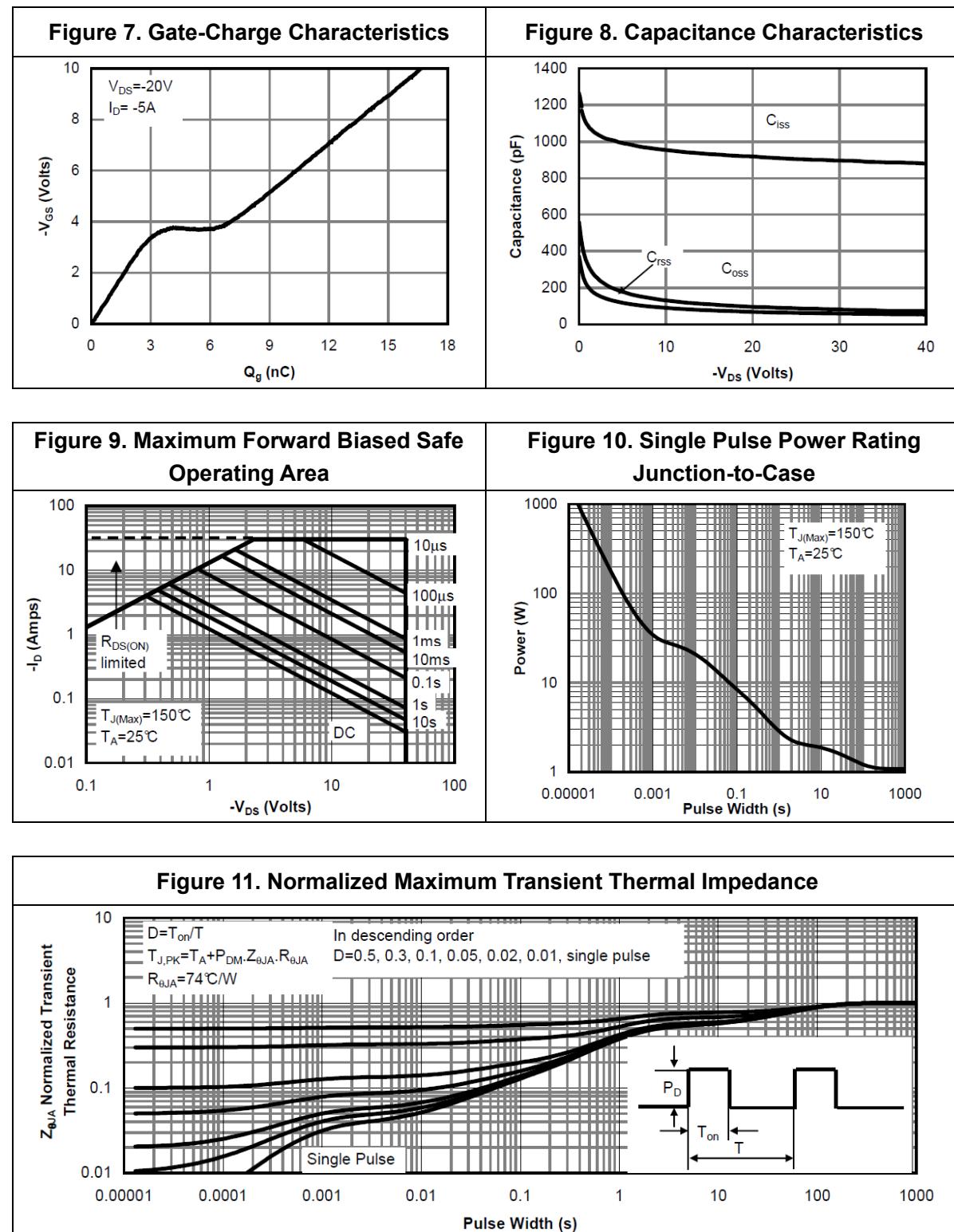
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-40\text{V}, V_{GS}=0\text{V}$	-	-	-1	μA
Gate -Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.1	-1.5	-1.9	V
Drain-Source On-stage Resistance	$R_{DS(\text{ON})}$	$V_{GS}=-10\text{V}, I_D=-1\text{A}$	-	16	20	$\text{m}\Omega$
		$V_{GS}=-4.5\text{V}, I_D=-1\text{A}$	-	26	32	

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$V_{DS}=-20\text{V}$	-	1220	-	pF
Output capacitance	C_{oss}		-	156	-	
Reverse transfer capacitance	C_{rss}		-	87	-	
Gate Resistance	R_g	$f=1\text{MHz}$	-	8.9	-	Ω
Total Gate Charge	Q_g	$V_{DS}=-20\text{V}$	-	17	-	nC
Gate Source Charge	Q_{gs}		-	3.5	-	
Gate Drain Charge	Q_{gd}		-	3	-	
Turn-on delay Time	$t_{d(\text{on})}$	$V_{GS}=-10\text{V}$	-	6.5	-	ns
Rise time	t_r		-	7.8	-	
Turn-off delay Time	$t_{d(\text{off})}$		-	45	-	
Fall time	t_f		-	40	-	
Body Diode Forward Voltage	V_{SD}	$V_{GS}=0\text{V}, I_{SD}=-1\text{A}$	-	-0.7	-1	V
Reverse Recovery Time	t_{rr}	$V_{GS}=0\text{V}, I_{SD}=-5\text{A}$	-	22	-	ns
Reverse Recovery Charge	Q_{rr}		-	15	-	nC

Q2: Electrical Characteristics Diagrams





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